

650V N-Channel Super Junction Power MOSFET

DESCRIPTION

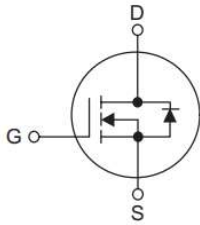
The **65R360F** use advanced super junction technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It has the low $R_{DS(on)}$, low gate charge, fast switching and excellent avalanche characteristics. This super junction MOSFET fits the industry's AC-DC SMPS requirements for PFC, AC/DC power conversion, and industrial power applications.

FEATURES

- * low $R_{DS(on)}$
- * SuperJunction Technology
- * Low on-resistance and low conduction losses
- * Ultra Low Gate Charge cause lower driving requirements

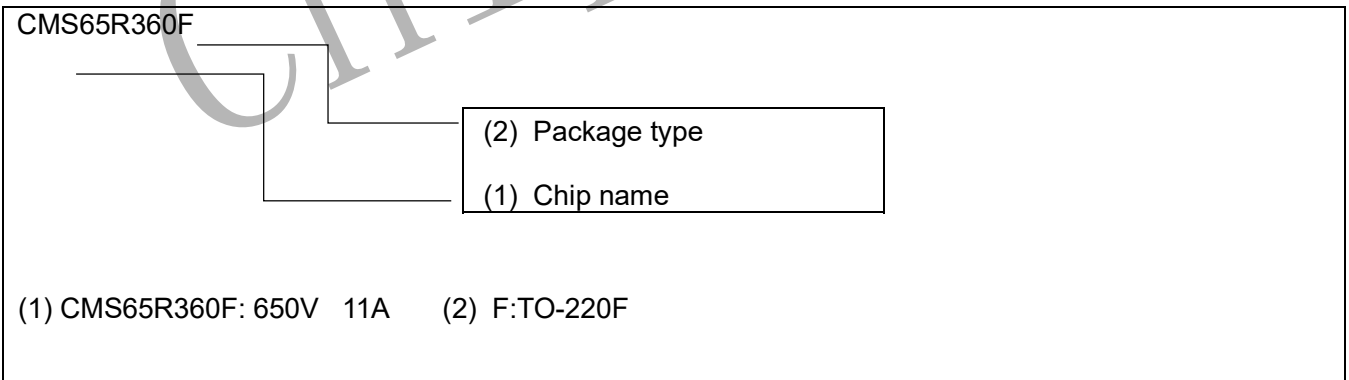
SYMBOL

1. Gate
2. Drain
3. Source



Package Description

Product Model	Package Type	Mark Name	Identification Code	Package
CMS65R360F	TO-220F	CMS65R360	F	Tube



ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DS}	650	V
Gate-Source Voltage		V_{GS}	± 30	V
Drain Current	Continuous($T_C=25^\circ\text{C}$)	I_D	11	A
	Continuous($T_C=100^\circ\text{C}$)		7	A
Drain Current	Pulsed (Note1)	I_{DM}	33	A
Avalanche Energy	Single Pulsed (Note2)	E_{AS}	280	mJ
	Repetitive Avalanche Energy (Note1)	E_{AR}	0.5	mJ
Drain Source voltage slope, $V_{DS} \leq 480\text{V}$		dv/dt	50	V/ns
Power Dissipation	$T_C=25^\circ\text{C}$	P_D	32.7	W
	TO-220F			
Junction Temperature		T_J	150	$^\circ\text{C}$
Storage Temperature		T_{STG}	55~+150	$^\circ\text{C}$

Notes:

- 1.Repetitive Rating:Pulse Width Limited by Maximum Junction Temperature.
2. $T_J = 25^\circ\text{C}$, $V_{DD} = 50\text{V}$, $V_G = 10\text{V}$, $R_G = 25\Omega$

THERMAL CHARACTERISTICS

Symbol	Parameter	PACKAGE	RATINGS	Units
$R_{\theta JC}$	Junction-to-Case	TO-220F	3.82	$^\circ\text{C/W}$
$R_{\theta JA}$	Junction-to-Ambient	TO-220F	80	$^\circ\text{C/W}$

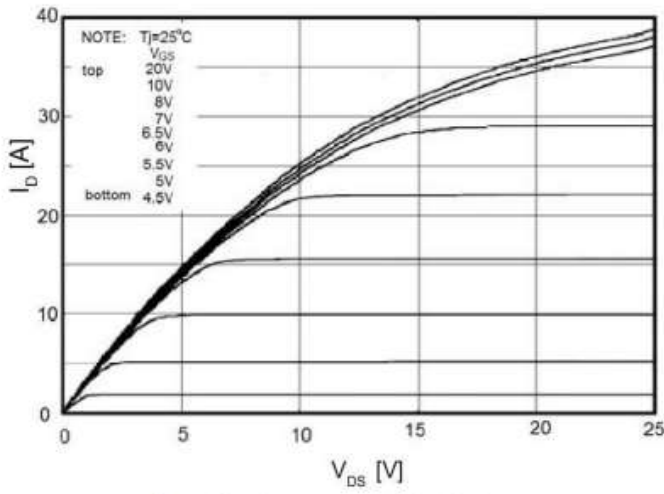
ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	$B_{V_{DS}}$	$V_{GS} = 0\text{ V}, I_D = 250\mu\text{A}$	650			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 650\text{ V}, V_{GS} = 0\text{ V}$			1	μA
Gate-Source Leakage Current	Forward	I_{GSS}			100	nA
	Reverse					
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2.0		4.0	V
Static Drain-Source On- Resistance	$R_{DS(ON)}$	$V_{GS} = 10\text{ V}, I_D = 7\text{A}$		300	360	$\text{m}\Omega$
DYNAMIC CHARACTERISTICS						
Input Capacitance	C_{ISS}	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V}, f = 1.0\text{MHz}$		1030		pF
Output Capacitance	C_{OSS}			87		pF
Reverse Transfer Capacitance	C_{RSS}			4.5		pF
SWITCHING CHARACTERISTICS						
Total Gate Charge	Q_G	$V_{DS} = 480\text{V}, I_D = 11\text{A}, V_{GS} = 10\text{V}$		23		nC
Gate-Source Charge	Q_{GS}			5.7		nC
Gate-Drain Charge	Q_{GD}			8		nC
Turn-On Delay Time	$t_{D(ON)}$	$V_{DD} = 380\text{V}, I_D = 5.5\text{A}, R_G = 6.8\Omega, V_{GS} = 10\text{V}$		9		ns
Turn-On Rise Time	t_R			4		ns
Turn-Off Delay Time	$t_{D(OFF)}$			40		ns
Turn-Off Fall Time	t_F			4.5		ns
Drain-Source Diode Characteristics and Maximum Ratings						
Maximum Continuous Drain-Source Diode Forward Current	I_{SD}				11	A
Maximum Pulsed Drain-Source Diode Forward Current	I_{SM}				33	A
Diode Forward Voltage	V_{SD}	$V_{GS} = 0\text{ V}, I_{SD} = 5.5\text{A}$			1.2	V
Reverse Recovery Time	t_{rr}	$V_R = 400\text{V}, I_F = 5.5\text{A}, diF/dt = 100\text{A}/\mu\text{s}$		245		ns
Reverse Recovery Charge	Q_{rr}				2.4	

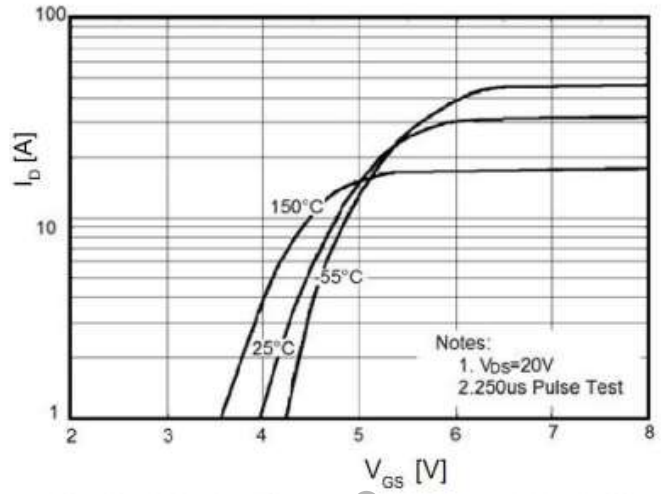
* Drain Current Limited by Maximum Junction Temperature.

TEST CIRCUITS AND WAVEFORMS

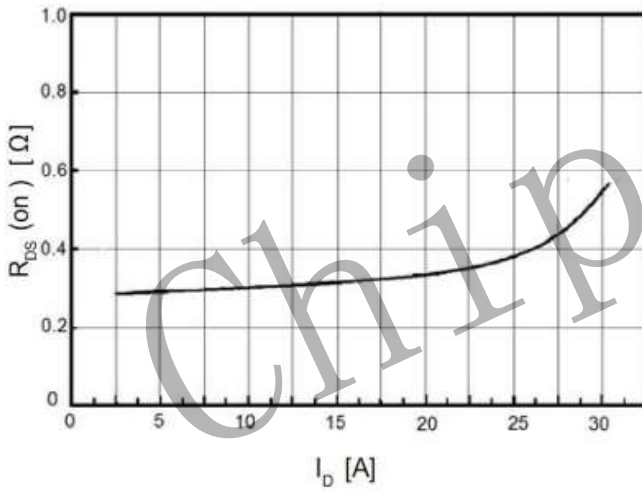
On-Regin Characteristics



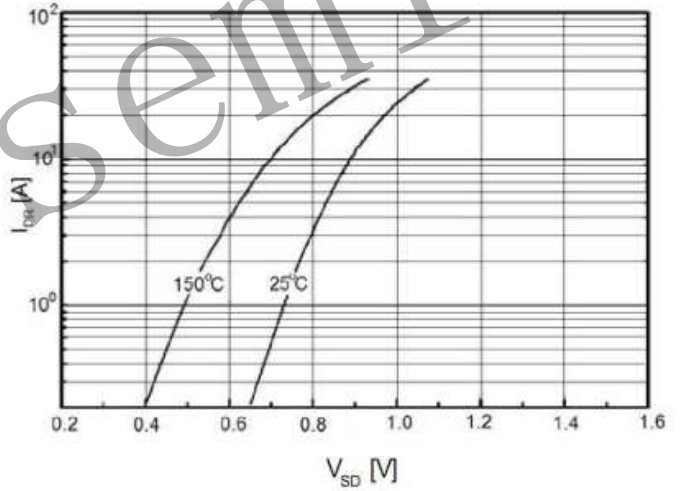
Transfer Characteristics



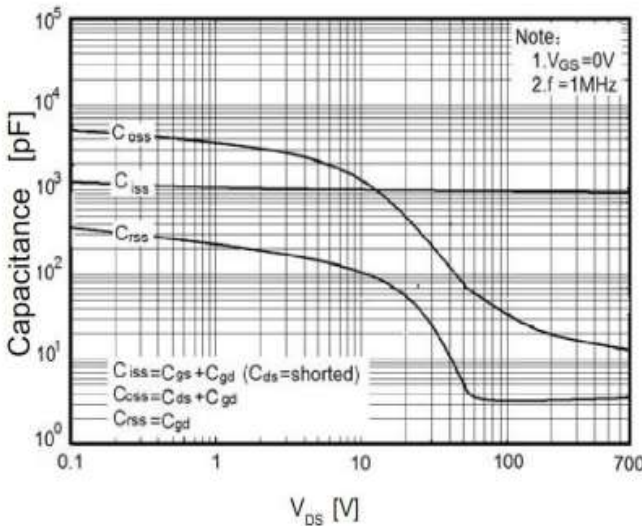
On-Resistance Variation vs. Drain Current and Gate Voltage



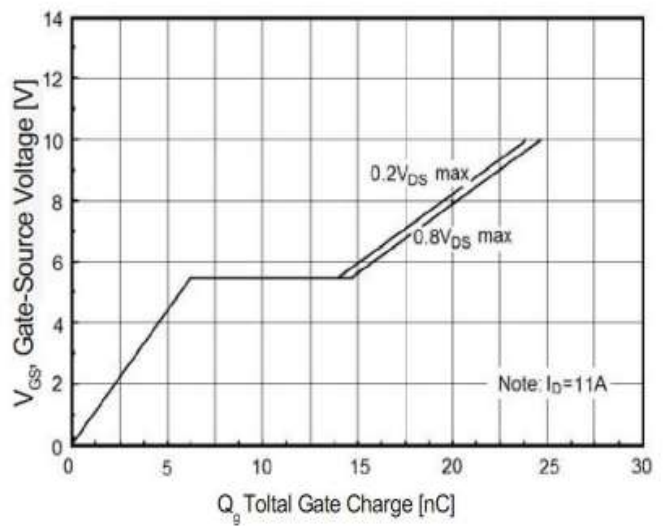
Body Diode Forward Voltage Variation vs. Source Current and Temperature



Capacitance Characteristics

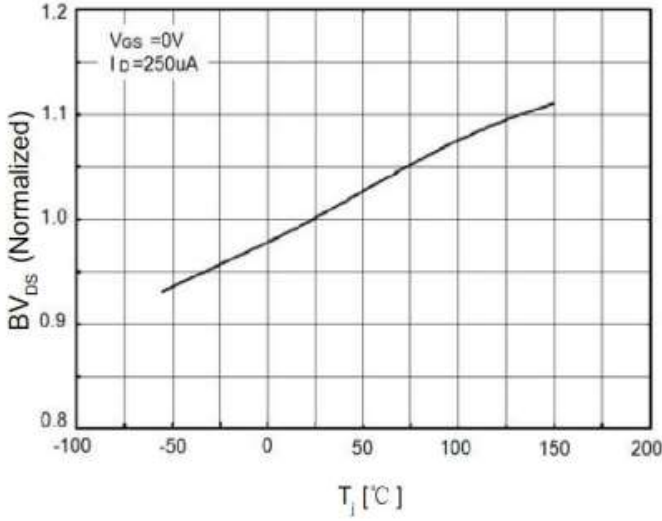


Gate Charge Characteristics

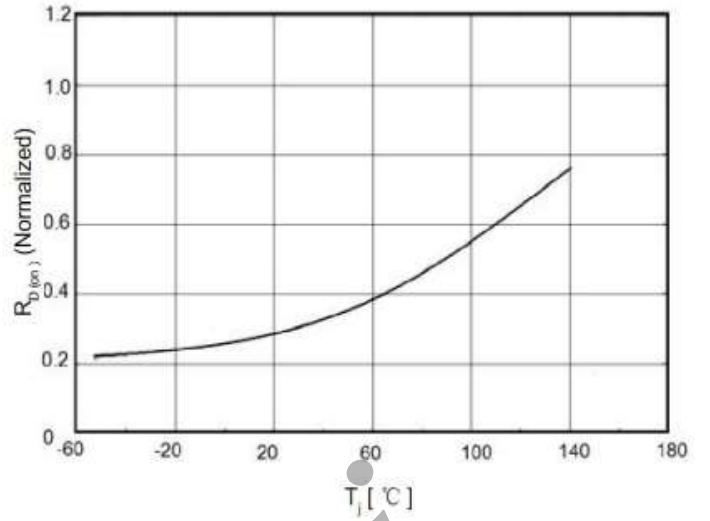


TEST CIRCUITS AND WAVEFORMS(Cont.)

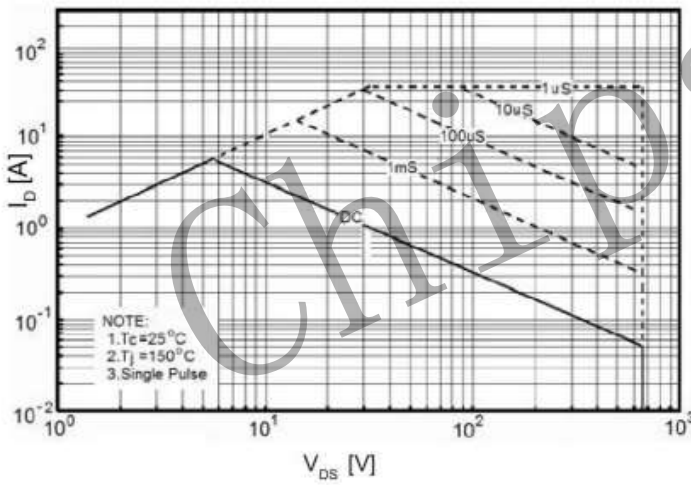
Breakdown Voltage Variation vs. Temperature



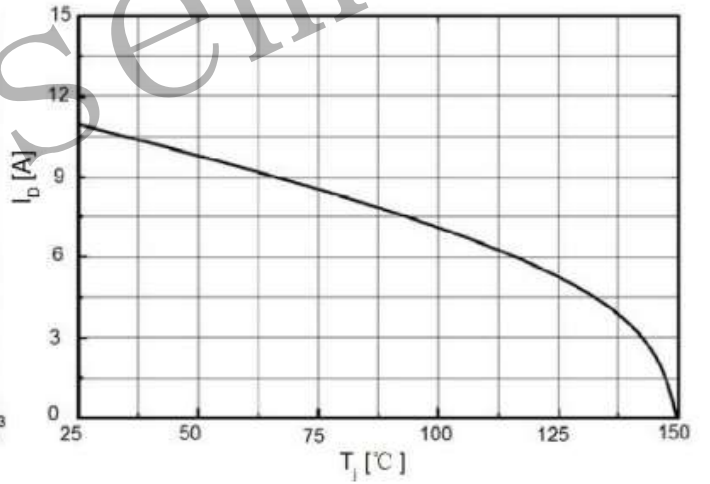
On-Resistance Variatio vs. Temperature



Maximum Safe Operating Area



Maximum Drain Curre Vs. Case Tempera



Attentions

- Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. Please do not exceed the absolute maximum ratings of the device when circuit designing.
- When installing the heat sink, please pay attention to the torsional moment and the smoothness of the heat sink.
- MOSFET is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
- Chipsemi reserves the right to make changes in this specification sheet and is subject to change without prior notice.

Appendix

Revision history:

Date		REV.	Description	Page
2023.3		1.0	Original	6